UNISONIC TECHNOLOGIES CO., LTD

4NM70-U2 ____ **Preliminary Power MOSFET**

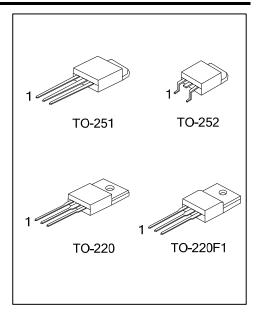
4A, 700V N-CHANNEL SUPER-JUNCTION MOSFET

DESCRIPTION

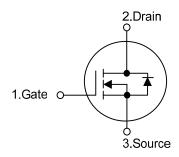
The UTC 4NM70-U2 is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications at power supplies, PWM motor controls, high efficient AC to DC converters and bridge circuits.



- * $R_{DS(ON)}$ < 2.20 @ V_{GS} =10V, I_{D} = 2.0A
- * Fast Switching Capability
- * Improved dv/dt Capability, High Ruggedness



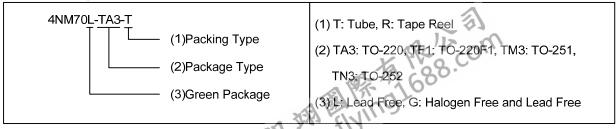
SYMBOL



ORDERING INFORMATION

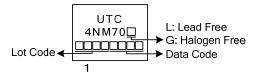
Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
4NM70L-TA3-T	4NM70G-TA3-T	TO-220	G	D	S	Tube	
4NM70L-TF1-T	4NM70G-TF1-T	TO-220F1	G	D	S	Tube	
4NM70L-TM3-T	4NM70G-TM3-T	TO-251	G	D	S	Tube	
4NM70L-TN3-R	4NM70G-TN3-R	TO-252	G	D	S	Tape Reel	

S: Source Note: Pin Assignment: G: Gate D: Drain



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MARKING





■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V _{DSS}	700	V	
Gate-Source Voltage		V _{GSS} ±30		V	
Drain Current	Continuous	I _D	4.0	Α	
	Pulsed (Note 2)	I _{DM}	16	Α	
Avalanche Current (Note 2)		I _{AR}	1.2	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	104	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4	V/ns	
Power Dissipation	TO-220		106	W	
	TO-220F1	P_{D}	36	W	
	TO-251/TO-252		49	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 144 mH, I_{AS} = 1.2 A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C
- 4. $I_{SD} \le 4.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25$ °C

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction-to-Ambient	TO-220/TO-220F1	0	62.5	°C/W
	TO-252	θ_{JA}	110	°C/W
Junction-to-Case	TO-220		1.18	°C/W
	TO-220F1	θ_{JC}	3.47	°C/W
	TO-251/TO-252		2.55	°C/W



ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

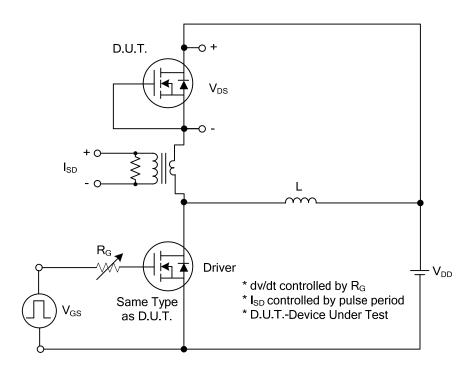
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV_DSS	V_{GS} =0V, I_D =250 μ A	700			V	
Drain-Source Leakage Current		I_{DSS}	V _{DS} =700V, V _{GS} =0V			1	μΑ	
Gate-Source Leakage Current	Forward	,	V_{GS} =30V, V_{DS} =0V			100	nA	
	Reverse	I_{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	IIA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$			4.5	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =2.0A			2.2	Ω	
DYNAMIC CHARACTERISTICS		_			=.	=.		
Input Capacitance		C _{ISS}			204		pF	
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		120		pF	
Reverse Transfer Capacitance		C_{RSS}			13		pF	
SWITCHING CHARACTERISTICS								
Total Gate Charge (Note 1)		Q_G	V _{DS} =50V, V _{GS} =10V, I _D =1.3A ,		32		nC	
Gate to Source Charge		Q_GS	I _G =100μA (Note 1, 2)		4		nC	
Gate to Drain Charge		Q_GD	IG-100μΑ (Note 1, 2)		7		nC	
Turn-ON Delay Time (Note 1)		$t_{D(ON)}$			36		ns	
Rise Time		t_R	V_{DD} =30V, V_{GS} =10V, I_{D} =0.5A,		56		ns	
Turn-OFF Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		90		ns	
Fall-Time		t_{F}			24		ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		Is				4.0	Α	
Maximum Body-Diode Pulsed Current		I _{SM}				16	Α	
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =4.0A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time (Note 1)		t _{rr}	I _S =4.0A, V _{GS} =0V,		280		ns	
Body Diode Reverse Recovery Charge		Q_{rr}	dI _F /dt=100A/μs		2.14		μC	

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

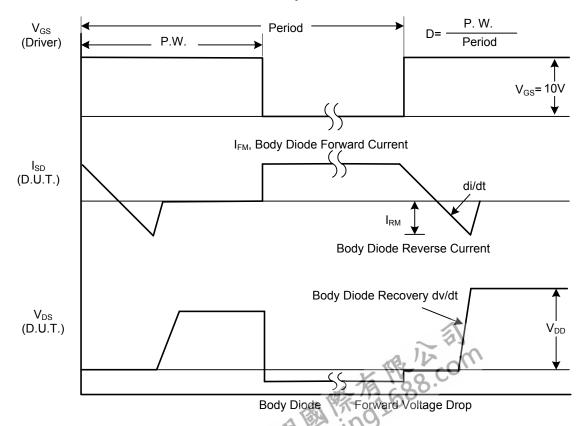


^{2.} Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

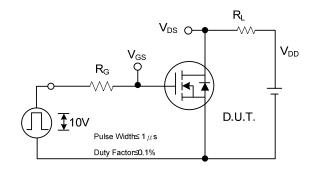


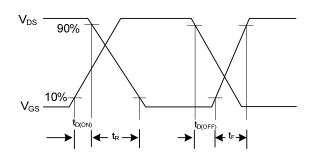
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

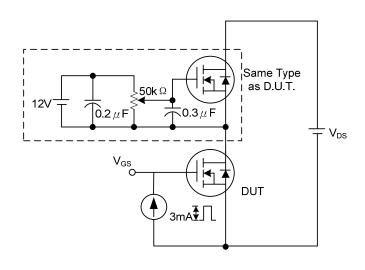
TEST CIRCUITS AND WAVEFORMS (Cont.)

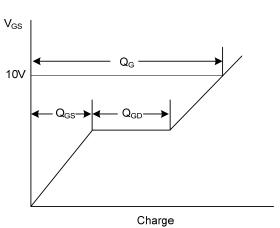




Switching Test Circuit

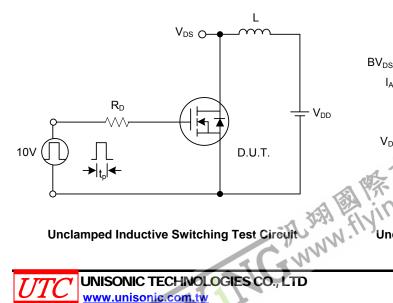
Switching Waveforms

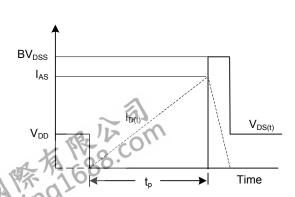




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Waveforms

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